Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/774,169	BAR ET AL.	
Examiner	Art Unit	
Thuong (Tina) T. Nguyen	2155	

SEARCHED			
Class	Subclass	Date	Examiner
709	218, 223, 224,225	4/9/2006	тн
713	152,166	4/9/2006	TH
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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		DATE	EXMR
IEEE		4/9/2006	тн
EAST		4/9/2006	тн